

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/656,629	MALAK ET AL.
	Examiner	Art Unit
	Christopher L. Chin	1641

Search Notes



Application/Control No.

10/656,629

Examiner

Christopher L. Chin

**Applicant(s)/Patent under
Reexamination**

MALAK ET AL.

Art Unit

1641

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)